


<b>Search Notes</b> 	<b>Application/Control No.</b> 10501640	<b>Applicant(s)/Patent Under Reexamination</b> DANKULICH ET AL.
	<b>Examiner</b> San-ming Hui	<b>Art Unit</b> 1617

SEARCHED			
Class	Subclass	Date	Examiner
514	182, 176	1/6/09	SH

SEARCH NOTES		
Search Notes	Date	Examiner
Structure search in STN, inventor search in PALM	1/6/09	SH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	182, 176	1/6/09	SH

	/S. H./ Primary Examiner.Art Unit 1617
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